

<b>Notice of References Cited</b>	Application/Control No. 10/570,829	Applicant(s)/Patent Under Reexamination YOSHINO, YOSHITAKA	
	Examiner Christian A. Hannon	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,821,158	11-2004	Iida et al.	439/660
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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